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Femtosecond temperature measurements of laser-shocked copper deduced from the intensity of the x-ray thermal diffuse scattering ⁽²⁾

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ABSTRACT

We present 50-fs, single-shot measurements of the x-ray thermal diffuse scattering (TDS) from copper foils that have been shocked via nanosecond laser ablation up to pressures above ~ 135 GPa. We hence deduce the x-ray Debye–Waller factor, providing a temperature measurement. The targets were laser-shocked with the DiPOLE 100-X laser at the High Energy Density endstation of the European X-ray Free-Electron Laser. Single x-ray pulses, with a photon energy of 18 keV, were scattered from the samples and recorded on Varex detectors. Despite the targets being highly textured (as evinced by large variations in the elastic scattering) and with such texture changing upon compression, the absolute intensity of the azimuthally averaged inelastic TDS between the Bragg peaks is largely insensitive to these changes, and allowing for both Compton scattering and the low-level scattering from a sacrificial ablator layer provides a reliable measurement of T/Θ_D^2 , where Θ_D is the Debye temperature. We compare our results with the predictions of the SESAME 3336 and LEOS 290 equations of state for copper and find good agreement within experimental errors. We, thus, demonstrate that single-shot temperature measurements of dynamically compressed materials can be made via thermal diffuse scattering of XFEL radiation.

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I. INTRODUCTION

The dynamical compression of condensed matter on nanosecond timescales, with the pressure applied via laser ablation of a surface layer, provides a means to reach pressures far greater than those that can be applied statically in diamond anvil cells (DACs).¹⁻³ Tailoring of the temporal profile of the applied optical laser radiation can lead to samples either being shock compressed to states along the Hugoniot or ramped more slowly to the highpressure state, keeping the sample cooler, and closer to the isentrope. Subsequent pulsed x-ray diffraction provides structural information on a timescale short compared with that of the nanosecond compression.⁴ This combination of laser-compression and pulsed diffraction has been applied at a number of high-power-laser, synchrotron, and XFEL facilities over the past few decades, providing a wealth of information on high strain-rate deformation physics and phase transitions at pressures from a few GPa to well into the multi-TPa regime, 5-21 which comprises a region of parameter space of relevance to the physics of planets both within our own solar system and beyond.

While density information can be provided by diffraction, pressure can be deduced via interferometric measurements of the velocity of an interface within, or the free surface of, the target via the VISAR technique (Velocity Interferometer System for Any Reflector).^{28,29} Temperature, however, has proven to be a more difficult parameter to measure within such dynamical compression experiments, particularly when the temperatures are too low to be extracted from pyrometric techniques for these small targets on such short timescales.^{30–32} One method that has proven successful at the Omega laser and at the National Ignition Facility (NIF) is EXAFS (Extended X-ray Absorption Fine Structure), where the depth of modulations in the x-ray absorption coefficient above a Kor L-edge is sensitive to the Debye-Waller (DW) factor (effectively proportional to T/Θ_D^2 , where Θ_D is the Debye temperature).^{33–35} If we assume that Θ_D as a function of compression can be calculated reliably, or inferred by other local sound-velocity measurements, then this method provides a means to extract temperatures. Alternatively, as has been done recently, the EXAFS signal can be compared directly with spectra produced from molecular dynamics simulations, bypassing the need to quote a specific value for the Debye temperature.

Although EXAFS measurements have been proven to provide temperature information on the facilities cited above, they are only made possible by the fact that the very large optical laser energies available at them allow for the creation of a separate, bright, short (subnanosecond), broad-band, and spectrally structureless laser-plasma-based diverging source of x rays, which are subsequently absorbed by the dynamically compressed target, and the resultant absorption spectrum recorded. Such a source is not readily available at x-ray FEL facilities, where a significant proportion of such compression studies are now performed. FEL facilities have the advantages provided by the highly monochromatic nature of the x-ray beam and its ultrashort pulse-length (which results in the x-ray source being considerably brighter than those provided by a laser-produced plasma). As a result, other methods of using the x rays to provide a temperature measurement at FELs have been sought.

One obvious candidate for a temperature measurement is the DW effect as applied to the elastic scattering, whereby the ratios of the intensities of the Bragg peaks are used to deduce $T|\mathbf{G}|^2/\Theta_{\rm D}^2$, where G is the reciprocal lattice vector associated with the Bragg reflection of interest. While in EXAFS the DW effect reduces the depths of the modulations in the absorption coefficient above an absorption edge as the DW factor increases, in diffraction, the intensity of the higher-order Bragg peaks decreases compared with those of lower order, and indeed, the total elastic scattering decreases with a concomitant increase in the thermal diffuse scattering (TDS). In both cases, the underlying physics is related to the thermally induced deviation of atoms from their perfect-lattice positions. For diffraction, this introduces a degree of randomization of the phase of the x rays scattered from each atom, whereas in the case of EXAFS, the phase of the ejected and re-scattered photo-ejected-electron is influenced (note that there are thus slight differences in the two DW factors, as EXAFS is probing shortrange order, while diffraction probes on longer lengthscales).

However, under the influence of dynamic compression, significant texture changes may take place within the sample, making such DW measurements via elastic diffraction difficult: the relative intensities of the Bragg peaks are heavily influenced by the overall orientation distribution function (ODF) of the grains within the sample, which itself changes owing to plastic flow (an issue that does not affect the EXAFS technique, as the absorption is independent of texture). Although simulations under elastic compression seem to indicate that the technique might have some merit,³⁶ previous experimental attempts to deduce DW factors from the elastic scattering from shocked samples probed with short pulses of x rays of synchrotron radiation have proven to be unsuccessful,³⁷ and it has been posited that the copious defects that are produced under shock compression may also influence the reliability of this approach. Indeed, $\frac{1}{4}$ within the measurements we present here, we have found that the Bragg-peak elastic scattering cannot be used to reliably extract DW is factors owing to texture, indicating that such an approach might only be feasible in situations where the target is largely free from texturing effects (which may be the case, for example, if its thermodynamic path has taken it through into the melt, with subsequent refreezing).

Given the difficulties associated with measuring the effects of the DW factor on the intensity of the Bragg peaks, it has recently been suggested that temperatures in such experiments at FELs could be obtained via spectrally resolved inelastic x-ray TDS from the phonons within the compressed sample,³⁸⁻⁴⁰ probing at momentum transfers between Bragg peaks. If such a method were feasible, it would have the advantage that the temperature measurement would rely solely on the principle of detailed balance (with no knowledge of the Debye temperature required), whereby the temperature is inferred merely from the ratio of the intensities of the Stokes and anti-Stokes peaks. However, given the thermal phonons within the compressed samples have maximum energies of just a few 10's of meV, yet, the incident x rays are of order 10's of keV, such experiments require an extremely high degree of monochromaticity in both the x-ray beam $(\lambda/\Delta\lambda > 10^6)$ and the associated light-collecting spectrometer, which consequently make them extremely photon hungry. Indeed, the scattering cross sections are such that with current total FEL x-ray energies of order a millijoule per pulse, it is likely that many hundreds, if not thousands, of identical shots would be required to build up sufficient signal to make a temperature measurement, even with narrow-band spectral seeding of the FEL beam, precluding the single-shot temperature measurements that are afforded by the EXAFS technique. Furthermore, as temperatures start to exceed the Debye temperature, the ratio of the Stokes and anti-Stokes components approaches unity, severely limiting the materials and range of temperatures over which this technique can be usefully employed.

It is in the above context that we demonstrate here that the absolute intensity of the spectrally unresolved (but resolved in a scattering angle) TDS between the Bragg peaks can provide a reliable measure of T/Θ_D^2 . As no spectral resolution whatsoever is required, such measurements can easily be made on a single-shot basis. Furthermore, we show that this inelastic scattering intensity, when averaged over a reasonable range of azimuthal angles, is much more robust against changes in texture than the elastic scattering and mainly depends on changes in the DW factor. This TDS signal, at least for the mid-Z target of Cu studied here, also dominates over both Compton scattering from the Cu and the scattering (elastic and Compton) from the low-Z ablation layer frequently used in such experiments (all of which can, furthermore, be taken into account in the analysis procedure).

We present results from laser-shocked Cu up to specific volume ratios V/V_0 of 0.7 (where V_0 is the specific volume of the ambient material), corresponding to pressures (according to the SESAME 3336 EOS⁴¹) of order 137 GPa. The intensity of the TDS is compared with predictions of a simple model based on the classic work of Warren.^{42,43} When we adapt the Warren model to take texture effects into account, we find negligible differences for the azimuthally averaged TDS between highly textured samples and random powders, demonstrating the applicability of the original simple Warren model to the TDS scattering (the same statement does not apply for the elastic Bragg scattering). Applying this model to the experimental data, we extract values of T/Θ_D^2 along the Hugoniot. We compare our results with the predictions of the LLNL LEOS 290⁴⁴ and SESAME 3336 EOS,⁴¹ both of which provide values for Θ_D and T along the Hugoniot. We also make comparison with the results of the historical shock compression experiments by Al'tshuler and co-workers, where temperatures were deduced from a Mie-Grüneisen model.45 Within the experimental error of our measurements, we find broad agreement with these models, thus demonstrating the feasibility of using single shot TDS as a temperature measurement for dynamically compressed matter.

This paper is laid out in the following manner. In Section II, we outline the experimental setup. Then, in Sec. III, we present the experimental results and show how they compare with simulations, thus allowing an extraction of the DW factor (and hence temperature if we assume a knowledge of Θ_D under compression). We compare our results with those predicted by the models referenced above. Finally, in Sec. IV, we discuss the results, the potential advantages and limitations of the technique, and comment upon ways whereby more accurate measurements of the DW factor could be made in the future.

II. EXPERIMENTAL SETUP

The dynamic-compression experiment was performed in Interaction Chamber 2 (IC2) of the High Energy Density (HED) scientific instrument at the European X-ray Free-Electron Laser (EuXFEL). We show the configuration of the target chamber in Fig. 1.

To shock-compress our targets, we used the recently commissioned⁴⁶ DiPOLE 100-X laser system.⁴⁷ Targets were irradiated with 10 ns pulses of frequency-doubled (515 nm) light containing up to 40 J of energy, concentrated into a drive spot of either 500 µm or 250 µm diameter depending on the desired pressure. For the 500-µm drive spot—which allowed access to values of V/V_0 of just below 0.75—we used a flat-top (constant intensity) laser pulse; for the very highest-pressure shots ($V/V_0 = 0.7$), driven using a smaller 250-µm drive spot, the laser intensity was linearly ramped by 10% over the course of the 10 ns pulse duration to prevent the decay of the ablation pressure. The laser energy was monitored by siphoning off a small portion of the main beam into a calorimeter situated outside the interaction chamber.

The targets comprised a 50-µm-thick polyimide (Kapton B, DuPont) ablator layer glued to a 25-µm-thick rolled Cu foil



FIG. 1. Experimental setup at the High Energy Density (HED) scientific instrument. Ablatively driven shock waves are launched using 10 ns pulses of frequency-doubled radiation from the DiPOLE 100-X laser into targets comprising a Kapton-B ablator of thickness $L_{BK} = 50 \ \mu m$ glued to a copper foil of thickness $\textit{L}_{Cu}=25\,\mu\textrm{m}.$ Targets are probed before shock breakout with a beam of 18 keV photons from the x-ray free-electron laser (XFEL) directed at angle $\omega = 22.5^{\circ}$ to the target normal. Resulting diffraction patterns are recorded on a pair of downstream Varex detectors placed symmetrically above and below the beam path. The targets' rear-surface velocity history is measured using a two-leg Velocity Interferometer System for Any Reflector (VISAR). (a) Close-up of the x-ray path through a partially compressed target. An x-ray incident at angle ω to the target normal and scattered into angle ζ traverses a shocked Kapton layer, a shocked Cu layer, and an ambient Cu layer, the latter having thickness $(1 - x)L_{Cu}$, where x is the mass fraction of the Cu traversed by the shock. (b) Simplified top-down view of the experimental setup, illustrating directions of the incident beams and shadowing of scattered x rays by the target.

(Goodfellow). Targets were diced into $5 \times 5 \text{ mm}^2$ tokens and mounted in the recesses of a ladder-type frame, which were separated from one another by at least 10 mm. To ensure repeatability, all targets were mounted with a consistent orientation such that their rolling direction (RD) was vertical to within a few degrees. We confirmed the consistency of the target orientations by comparing their 'pre-shots' (diffraction patterns obtained on the ambient target prior to shock-compression), and verifying that the azimuthal structure in their Debye–Scherrer rings was compatible with a single underlying crystallographic texture. For the rolled foils used in this experiment, the dominant component of an orientation distribution function (ODF) was largely consistent with a β -fiber texture, which is often seen in such copper samples.

Our primary diagnostic was femtosecond x-ray diffraction. We illuminated the shock-compressed targets with 50 fs bursts of 18 keV x rays traveling at angle $\omega = 22.5^{\circ}$ to the target normal and coincident with the center of the optical drive spot. This incidence angle represented a compromise between several competing experimental constraints, the most important of which being that the three drive and diagnostic beams cannot be collinear. The x-ray spot size was set to 45 µm for shots taken with the larger 500 µm drive spot and reduced to 20 µm for higher-pressure shots taken using a 250 µm spot. We endeavored to time the x-ray pulse relative to the onset of the drive laser so as to probe the targets just before the shock wave reached the rear surface of the Cu layer. We were generally successful in timing our shots such that the fraction of the Cu layer traversed by the shock [referred to as x in Fig. 1(a)] was at least 60%. However, the demands of the inelastic scattering measurement are such that for the most accurate measurements, we needed to sift our data for shots for which $x \ge 0.8$; this will be addressed further in Sec. III. The shot-to-shot XFEL intensity was measured using an x-ray gas monitor (XGM) 108.8 m upstream of the center of the target chamber, with an absolute measurement accuracy of $\pm 10\%^4$ (see the supplementary material).

X-ray diffraction patterns were recorded on a pair of 4343CT Varex flat-panel detectors. The detectors were placed symmetrically above and below the x-ray beam path at a distance of 225 mm from the target and rotated through 45° about the vertical, thus giving azimuthal angular coverage over the domain $\varphi \in (-80, 80)^{\circ}$ and polar coverage over $2\theta \in (5, 65)^{\circ}$. Diffraction beyond a scattering angle of 65° was generally weak due to self-attenuation from the target itself [see Fig. 1(b)]. We deduced the detector positions precisely by fitting diffraction patterns from standard powderlike CeO₂ calibrants using the DIOPTAS software package.⁴⁹

While the HED instrument does house a two-leg line-imaging VISAR instrument, whose beams independently monitor the motion of the copper layer's rear surface, data collected in our experiment (which was a component part of the first experiments performed on this facility by the user community) were of insufficient quality to extract rear-surface velocities from fringe shifts, and the VISAR instrument was, thus, principally used to measure shock breakout times, as has been reported elsewhere.⁴⁶ As a result, we shall present our results as a function of the specific volume ratio, V/V_0 , as determined directly from the x-ray diffraction, and the pressures we quote will be those predicted by the SESAME 3336 equation of state for the associated compression.

III. EXPERIMENTAL RESULTS

Our aim is to measure the intensity of the angularly resolved x-ray TDS from the shocked region of the copper sample. As we shall find below, when copper is shocked from ambient conditions to values of V/V_0 order 0.7, the strength of the TDS in the regions of interest, between the Bragg peaks, changes by factors of around two to three, and it is this intensity change that is ultimately a measure of the DW factor, and which we shall also show is insensitive to texture. A number of effects need to be taken into account in order to achieve this goal with the degree of accuracy, which will allow us to infer a meaningful temperature measurement.

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First, we need accurate measurements of the incoming x-ray flux on each shot, to which we can normalize the intensity of the diffracted x rays recorded on the Varex detectors. Such x-ray flux measurements were made by use of the X-ray Gas Monitor (XGM) discussed in Sec. II.

Second, the largely structureless $50-\mu m$ thick Kapton ablator layer will scatter over a wide range of angles both due to elastic scattering and to incoherent Compton scattering, and this combined scattering must be subtracted from the overall experimental signal if only the scattering from the copper is to be considered. We shall show that owing to the fact that Kapton is of much lower average atomic number, the total scattering from it is weaker than the TDS from the copper.

Third, at the photon energies used here (18 keV), for Cu, the incoherent Compton scattering cross section is non-negligible, and when integrated over all angles has a value approximately 15% of that of the elastic scattering.^{50,51} We will show below that this ²⁴ implies that the Compton scattering from the Cu is still well below ⁶/₂ the TDS signal, even under ambient conditions, yet is of a level that ²⁸/₂ its contribution to the overall scattering must be subtracted out.

Fourth, as well as x-ray scattering, x-ray absorption is taking blace, both while x rays traverse the target as they propagate along the incident FEL beam direction, and subsequently after they scatter, as they make their way through the target to the detector, as illustrated in Fig. 1(a). This effect can readily be taken into account by using the known absorption coefficient of the target.⁵² In addition to this angle-dependent absorption within the target itself, photoelectric absorption in the aluminum filter covering the Varex detectors must also be accounted for, as has been discussed in reports of previous experiments on this facility.⁴⁶

Last, we note that not all of the copper target is shocked at the time the diffraction pattern is recorded. Clearly, we would like the vast majority of the target to be in the shocked state, and we need to know what fraction has been shocked (the *x* in Fig. 1). We will show how *x* can be determined from a measure of the intensity of the diffraction from the thin unshocked layer of Cu at the rear of the target. We will also show that the statistical uncertainty in our measurements decreases markedly for those shots where x > 0.8.

The initial points mentioned above can be further elucidated by consideration of data obtained from unshocked targets. In Fig. 2, we show the Varex images of the diffraction from an unshocked target, which comprised a Kapton-coated 25- μ m thick copper foil (as described in Sec. II). Raw data from the Varex detectors have been transformed into (2 θ , ϕ) space by use of DIOPTAS,⁴⁹ which takes into account the effects of polarization and the solid



FIG. 2. Diffraction data collected on the Varex detectors on an unshocked copper sample. The intensity is corrected for x-ray polarization, the per-pixel solid angle, and the attenuation due to the aluminum filter.

angle subtended to the target by each pixel. We have also removed the effects of the angle-dependent absorption due to the filter over the detector (but not the effects of absorption within the target itself). It can be seen that we are recording scattering angles 2θ that range from below 10° up to around 60° , and for ambient copper, we can readily observe all diffraction peaks up to the degenerate (333)/(511) reflections. The azimuthal coverage in the angle ϕ is dependent upon the scattering angle, but as can be seen, this coverage is large and, in total, can extend up to almost 120° .

The azimuthal average of the data from Fig. 2 is shown in Fig. 3. On the same plot, we show the diffraction signal from a target that simply comprises $50 \,\mu\text{m}$ of Kapton. This signal is also corrected for polarization and pixel solid-angle effects, and the filter over the detector. However, to enable us to see the relative contribution that the Kapton makes to our Kapton-coated copper data, on this plot, we have reduced the intensity of this signal by an amount corresponding to passing through a 25- μ m thick Cu target at the appropriate scattering angles. It can thus be seen that the total scattering from the Kapton alone is at least a factor of two weaker than the scattering from the target comprising 25- μ m Cu coated with Kapton over the whole range of scattering angles, save



FIG. 3. Diffraction signal from an unshocked 25-µm thick Cu sample overcoated with 50-µm of Kapton, and, on the same scale, the diffraction signal from 50-µm Kapton with the x-ray attenuation due to the copper applied. Also shown is the sum of Voigt-profile fits to the Bragg peaks of the Cu sample.

a region below the Cu (111) peak, where it also starts to exhibit some structure.

Also shown in Fig. 3 is the sum of pseudo-Voigt profile fits to the elastic Cu Bragg peaks, using relative peak intensities expected of a perfect random powder for simplicity. Note from these fits that we can deduce that in the region between the Bragg peaks, the observed additional scattered intensity is not due to the wings of the Bragg peaks and, thus, not due to defect-induced peak broadening, but is primarily caused by thermal diffuse scattering. This can be demonstrated by modeling the diffraction from the Cu according to the classic theory of Warren,^{42,43} with higher-order scattering calculated using the approximation due to Borie.⁵³

In Warren's classic theory of TDS (which for the sake of completeness, we summarize in the supplementary material), in the limit of temperatures comparable to or greater than the Debye temperature, the TDS for a randomly oriented powder sample of a given crystal type (here face-centered-cubic) as a function of $a \sin \theta / \lambda$, where *a* is the lattice parameter, and λ the wavelength of the x rays, depends on (twice) the DW factor 2*M*, which for an element of mass *m* is given by

$$2M = \frac{12h^2}{mk_B} \frac{T}{\Theta_D^2} \left(\frac{\sin\theta}{\lambda}\right)^2.$$
 (1)

Warren also details how to calculate the elastic scattering for individual Bragg peaks.⁴³ Using the simple Warren theory, we show in Fig. 4 the predicted elastic and TDS scattering from a 25- μ m thick Cu foil, including the effects of absorption within the Cu (and



FIG. 4. Total simulated diffraction from an unshocked 25-µm thick Cu sample overcoated with 50 µm of Kapton, compared with an experimental pattern. (a) Comparison at the scale of the Bragg peaks, with the modeled signal offset by 0.5° for clarity. (b) Comparison at the inter-peak scale, breaking the signal down into elastic, thermal diffuse, and incoherent (Compton) scattering produced by the copper and the total scattering produced by the Kapton. Coherent parts of the Cu signal are modeled assuming a perfectly random powder.

assuming, at this stage, random texture—we will consider the issue of the effects of texture below). While the individual intensities of each of the experimental Bragg peaks do not quite fit the Warren theory (and this is indeed due to texture), it is clear that there is an excellent fit to the TDS. We note that while TDS has previously been registered at an XFEL, and its increase observed as the sample has been driven into the melt, direct quantitative comparison with the Warren model has not been made.⁵⁴

In Fig. 4, we also show the predicted total scattering from the Kapton sample, where we have assumed that the Kapton is completely structureless (i.e., we simply make the appropriate sum of the squares of the atomic form factors) to calculate the elastic scattering, and we calculate the incoherent (Compton) scattering using data from Hubbell and co-workers.⁵⁰ Also shown is a calculation of the incoherent (Compton) scattering from Cu (note that this starts to fall off slightly at higher scattering angles due to absorption within the Cu target). Figures 3 and 4 together clearly illustrate two important points: we are indeed measuring the inelastic TDS between the Bragg peaks, and that it is several times more intense than both the overall scattering from the Kapton and the incoherent scattering from the Cu (all of which can subsequently be taken into account in our analysis of the TDS).

Before considering data from shocked samples, we now consider briefly the effects of texture. In the supplementary material, we describe how we have adapted the classic theory of Warren both for the elastic Bragg scattering and the inelastic TDS to take into account texture effects. In the Debye–Scherrer geometry, when viewed in reciprocal space, elastic scattering occurs when the Ewald sphere (of radius the incident k-vector) intersects the Polanyi spheres (the spheres with radii corresponding to the magnitude of the reciprocal lattice vectors of allowed reflections). In the Warren theory, first-order inelastic TDS can occur at a point on the Ewald sphere by the addition of the wavevector of a phonon to the wavevector of a point on the Polanyi sphere. Warren makes the assumption that the Brillouin zone can be approximated as a sphere, with the radius q_B of this sphere for a face-centered-cubic crystal (and thus the wavevector of the most energetic phonon) given by

$$q_B = \frac{2\pi}{a} \left(\frac{3}{\pi}\right)^{\frac{1}{3}}.$$
 (2)

For a perfectly random powder, the scattering power of a point on a given Polanyi sphere is uniform and proportional to multiplicity of the reflection, giving rise to uniform Debye–Scherrer elastic scattering rings (as a function of azimuthal angle and neglecting the Lorentz factor, etc.), and results in the standard Warren formula for TDS. In essence, our texture-dependent modification to the Warren model comprises numerically integrating the contributions to both the elastic scattering and TDS, based on an appropriate weighting of all of the different points on the Polanyi spheres, having calculated those weightings from a given ODF determined by the texture. Importantly, we find that while the azimuthally averaged relative intensities of the elastic Bragg peaks are, as expected, significantly modified by texture, this is not the case for the TDS.

In order to demonstrate the veracity of the above statement, in Fig. 5, we plot the simulated azimuthally averaged elastic and inelastic TDS scattering from copper, ignoring here the effects of absorption, under ambient conditions for both a perfect powder, and for a β -fiber sample with a 5° spread, where the incident x-ray direction, sample normal, and fiber-axis correspond to those in the experiment, and the azimuthal average has been taken over the same range as that of the experimental data. We choose this texture as the elastic peaks seen in our experimental data are consistent with a large β -fiber component. It is clear that the elastic scattering changes considerably due to texture effects-note, in particular, the large differences in intensity of the (220) and (222) peaks between the textured and untextured sample-but, in contrast, the changes to the TDS are small in regions between the Bragg peaks. Indeed, even if we change the texture (with a simple plasticity model), we find changes in the intensity of the TDS scattering of less than 5%, a figure that is small compared with the 200%-300% changes in the inelastic TDS intensity that we shall find upon shock compression.



FIG. 5. Azimuthally integrated (a) elastic x-ray scattering and (b) thermal diffuse scattering for an fcc random powder predicted by the analytic solution of Warren⁴³ (black). Also shown are results from the present numerical model (magenta) for a β -fiber-textured polycrystal with surface normal inclined at 22.5° to the incident x rays. The elastic scattering peaks for the powder case have been offset by 0.5° to enable intensity differences compared with the powder case to be seen.

The insensitivity of the TDS to texture occurs because for a particular point in reciprocal space, away from the Polanyi spheres, inelastic scattering can occur via the additional wavevector of phonons from all points on the Polanyi sphere that lie within a wavevector of magnitude the Brillouin zone. As so many points on the Polanyi sphere are thus sampled (albeit with an integral over phonon wavevectors that differs from that of the perfect powder), the effects of nonuniform scattering power on the Polanyi sphere (i.e., texture) is sufficiently smoothed that it is drastically reduced for the TDS. Indeed, as is well known, inelastic scattering is still observed in this geometry even in the case of a single crystalthough in that case, its distribution throughout reciprocal space would start to exhibit the symmetry of the crystal. In the case of samples textured to the degree used in this experiment, however, it is clear that the azimuthally averaged TDS differs negligibly from the uniform powder case, allowing us to ignore the effects of texture upon it. These findings are consistent with previous calculations of inelastic scattering from textured samples, which also find only small differences between them and random powder samples.⁵⁵ In contrast, the elastic scattering (i.e., the relative intensities of the Bragg peaks) strongly depends on texture, even when azimuthally averaged, as the elastic scattering for a particular peak corresponds to a distinct line in reciprocal space, defined by the intersection of the Ewald sphere with the Polanyi sphere, with no large averaging over the surface of the sphere. As the intensity of the Bragg peaks themselves are so sensitive to texture, and the texture itself changes under shock compression due to plastic flow, we cannot easily extract the DW factor from the relative intensities of the Bragg peaks.

Having shown above that the azimuthally averaged TDS is Having shown above that the azimuthally averaged TDS is his insensitive to texture, we now consider data from shockcompressed targets. Note that for each target, a diffraction pattern was obtained under ambient conditions and subsequently during the passage of the shock. The relative intensities of the two patterns can be compared by normalizing them to the incoming x-ray flux (via use of the XGM detectors).

As noted above, in order to observe the shock-induced changes in the DW factor, exhibited by changes in the intensity of the TDS, we require a large measurable fraction of the Cu target to be shocked at the time when the diffraction pattern is recorded. This fraction is deduced from the intensity of the diffraction from the thin rear layer of the target, which is yet to be shocked, as illustrated in Fig. 6, where we show the diffraction signal from a Cu target shock compressed to a relative volume of 0.93, corresponding to a pressure (according to SESAME 3336) of order 12 GPa. Note that as well as the shift in the Bragg peaks to higher angles due to the shock compression, we are still recording far weaker Bragg diffraction from a layer of ambient material [the layer of thickness $(1 - x)L_{Cu}$] in Fig. 1.

The fraction x can be ascertained by comparing the intensity of the diffraction from this unshocked layer with that of the target before shock compression. Figure 6 also shows these pre-shot data, but reduced in intensity by an amount corresponding to the x rays first having to pass through 0.96 of the target of the target (which in this particular case is our deduced shocked fraction) such that the intensity of its Bragg peaks aligns with those from the unshocked regions of the driven target. Note that not every one of

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FIG. 6. The x-ray diffraction pattern from a sample shock compressed to a relative volume of 0.93 (a pressure, according to the SESAME 3336 EOS, of 12 GPa). Diffraction from a 25- μ m thick ambient sample is also shown, as is the calculated signal (taking into account photoelectric absorption) for the unshocked region of a shocked target such that the thickness of the shocked region is x = 0.96.

the Bragg peaks exactly fits this thickness, and this is due to the effect that the target is moved between the pre-shot and the main shot, and there are variations in the sampled texture of the foil. A least-squares fitting must, therefore, be performed, by which, in this particular case, we find that our error in x is ± 0.01 . The full procedure for deducing the shock fraction, x, along with the error analysis, is outlined in the supplementary material.

In order to have sufficient sensitivity to small shock-induced changes in the TDS, we need the vast majority of the target to be in the shocked state: not only will a large unshocked fraction result in a small overall change in the relevant TDS being observed, but it should also be borne in mind that we wish to ascertain the TDS signal of the shocked material approximately midway between the elastic Bragg peaks of the shocked material, to ensure that we differentiate between it and the elastic scattering; yet, this is also the region between the Bragg peaks where the TDS minimizes. In addition, at higher and higher shock compressions, the Bragg peaks (and nearby TDS) from the unshocked region will start to encroach at the same scattering angles as those at which we are measuring the TDS from the shocked region. It is also the case that the scattering from the shocked material (our signal) is absorbed within the as-yet unshocked material, causing further degradation in our signal if the shocked fraction is not sufficiently large. The final errors in any single datum, thus, vary as a function of both shock pressure and x. For the range of compressions observed in our experiment, we find that for the error in our measurements of the DW factor to be dominated by the error due to the XGM (i.e., measurement of scattering intensity), we require greater than 80% of the target to be in the shocked state. This will become evident in the data we present below.

In Figs. 7(a)-7(g), we show these diffraction signals for ambient material and for the six data shots that we have for

x > 0.8, where the diffracted intensity is now plotted as a function of $(a \sin \theta / a_0)$, where a is the lattice spacing of the sample under compression and a_0 the lattice spacing of the ambient material. These experimental data are fully corrected for extrinsic corrections to the scattering signal and has had contributions from the ablator scattering, Cu Compton scattering, and (for driven shots) TDS scattering from any remaining uncompressed Cu removed such that the only scattering remaining between the Bragg peaks is TDS from the compressed Cu. On each of the individual plots, we also show the best fit to the TDS for the ambient material such that the changes in the intensity of the TDS upon compression can be seen for each individual plot. This effect of shock compression on the magnitude of the diffracted signal can be seen even more clearly when all of the data are plotted together; this is shown in Fig. 7(h). Note, for all of the data shown in Fig. 7, we have removed the lowintensity Bragg peaks from the unshocked material for clarity, and these regions can be seen as breaks in the data at the same scattering angles. In Fig. 7(i), we show all of the best fits of the TDS scattering for each of the shots: the good agreement between the fitted TDS and the experimental data in Fig. 7(h) is readily apparent.

It can be seen that there is a systematic change in the intensity of the TDS with shock pressure, and in the regions between the (200) and (220) peaks, the (220) and (311) peaks, and the (222) and (400) peaks, the intensity increases by a factor between two and three at the highest shock pressures, but only starts to rise significantly above a relative volume of 0.81 (a pressure of 52 GPa according to SESAME 3336). Note also that at high shock compressions, the high-order diffraction peaks actually start to become dominated by the TDS, rather than elastic scattering, illustrating the difficulties that would ensue by attempting to measure the DW factor from the ratios of just the elastic peaks if the TDS is not taken into account, even if texture were not an issue. Indeed, for the (331) and (420) peaks, almost all of the scattering we observe is TDS at a compression of 0.7. The fact that a significant fraction of the intensity of a diffraction peak can actually be due to TDS at high temperatures has long been recognized.^{43,56}

In order to extract values of the DW factor, we perform a least-squares fit to the data of the predictions of the Warren model for the TDS as a function of 2M, where we constrain the fit to be in three specific locations in the diffracted signal. These three positions are midway between the (200)/(220) peaks, the (220)/(311) peaks, and the (222)/(400) peaks, where in each case, we fit over a range of angles corresponding to a width of 20% of the 2θ separation between the peaks. These three regions are shown shaded in each of Figs. 7(a)-7(g). These positions are chosen as they correspond to the scattering angles where the TDS significantly dominates over any contribution that could be attributed to the wings of the Bragg peaks. For example, as can be seen in Fig. 7, the (311) and (222) peaks are sufficiently close together that the TDS intensity cannot be accurately ascertained. The best fit for the Warren model for each of the data shots is also shown in Figs. 7(a)-7(g), and all of the fits shown together as a function of $(a \sin \theta/a_0)$ in Fig. 7(i).

To assign statistical errors to the DW factors, we execute our entire data-correction and fitting routine in a Monte-Carlo loop. For each shot, we repeatedly sample the XGM measurement distribution (a normal distribution with standard deviation $\sigma = 0.1$) to



FIG. 7. Overview of the exemplary dataset—including only those shots for which the shock fraction $x \ge 0.8$ —and thermal diffuse scattering (TDS) fitting results. (a)–(g) Experimentally measured diffraction intensity with ambient TDS, ablator, and Compton scattering subtracted (solid black lines) and a simulated TDS signal (broken colored lines) for compression ratios V/V_0 between unity (ambient data) and 0.70. For (b)–(g), the fitted ambient TDS is shown by a solid gray line for reference. Shaded regions show the domains of the experimental diffraction patterns used to fit Warren's TDS model. (h) Aggregate of the experimental data (labeled by run number (r----), shock fraction x, and compression ratio V/V_0) with the inset showing variation of the signal within the first fitting window, including $\pm 1\sigma$ intervals. (i) Aggregate of simulated TDS signals, labeled similarly. All data are plotted with abscissa a sin θ/a_0 , where a and a_0 are the compressed and ambient lattice constants, respectively.

generate a set of diffraction patterns whose normalizations are consistent to within statistical uncertainty; we do this not only for the signal from the driven shot itself, but also for the reference signals that we use to infer the Kapton scattering, and the ambient Cu scattering, and the shock fraction x (meaning uncertainty in the XGM signal enters into the error-propagation procedure at multiple junctures). We accumulate at least 10^3 fits of 2*M* and calculate the standard deviation of the resulting distribution. Full technical details of the error-propagation procedure are provided in the supplementary material. The values of the DW factor as a function of compression corresponding to the fits to the data shown in Fig. 7 for the region midway between the (200) and (220) peaks are shown in Fig. 8. Values of the pressure-dependent Debye temperature Θ_D predicted by LEOS 290 have been used for illustration. It is interesting to note that the DW factor is predicted by the EOS model to initially slightly decrease upon compression, and the data are evidently consistent with this very effect, albeit with an error bar of a magnitude that would prevent us from claiming to have conclusively observed it. Such a reduction in 2*M* upon weak shock compression has



FIG. 8. The Debye–Waller (DW) factor, 2*M*, as a function of compression, sampled at the (pressure-dependent) 2*θ* angle midway between the (200) and (220) Bragg peaks. Discrete points show the DW factors inferred by fitting the experimental data, using Debye temperatures predicted by LEOS 290. Overlaid are the DW factors calculated using the Hugoniot density, temperature, and Debye temperatures predicted directly by the thermal equations of state SESAME 3336 and LEOS 290. We also show the DW factor calculated using Grüneisen-parameter measurements by Al'tshuler,⁴⁶ assuming an ambient Debye temperature of 311 K.⁵⁷

previously been predicted.³⁶ At low shock pressures, the rise in the Debye temperature has a greater influence than the small increase in the material temperature, along with the increase in the length of the scattering vector. This is due to the fact that at low shock strengths, the Hugoniot remains close to the isentrope. By definition, along an isentrope, (T/Θ_D) remains constant, and thus, the increase of Θ_D with compression leads to a decrease in the $T|\mathbf{G}|^2/\Theta_D^2$ (where **G** now corresponds to the point in reciprocal space associated with the scattering vector), as long as the effective Grüneisen parameter exceeds 2/3.³⁶ At higher shock pressures, as the Hugoniot deviates further from the isentrope and significant shock heating occurs such that the temperature rise dominates over any increase in the square of the Debye temperature, the DW factor increases.

The temperatures that we deduce will depend on our model of the Debye temperature as a function of compression, for which there are a number of predictions that we can employ. Here, we consider two thermal equations of state that have been used to model shock-compressed copper, and to which experimental data were also compared for the EXAFS work referred to previously,³⁵ namely, the SESAME EOS 3336 and LEOS 290. Both of these model equations of state make specific predictions both for the Debye temperature itself and for the temperature along the Hugoniot.

In Fig. 9, we plot the temperature as a function of compression that our data imply if we use the Debye temperatures from the SESAME 3336 and LEOS 290 equations of state, alongside the temperatures on the Hugoniot that those models themselves predict. We also plot the temperatures deduced from some of the first experimental data for shocked Cu obtained at these compressions, due to Al'tshuler and co-workers,⁴⁵ where the temperatures were derived using a Mie–Grüneisen model, and represent an extension of lower-pressure data collected in the original work of Walsh *et al.*⁵⁸ Figure 9(a) shows the temperatures deduced from the data set shown in Fig. 7—i.e., those data for which x > 0.8. In order to show how the errors in our measurement increase for those shots with lower shock fractions, in Fig. 9(b), we have plotted the temperatures deduced for our full data set, which includes shots for which x can be as low as 0.6. A comparison of these two plots demonstrates the increase in our errors for lower shock fractions, though as noted above, the way that the errors propagate are a non-trivial function of both shock fraction and the degree of compression, given the way that the scattering from the unshocked and shocked portions of the crystal overlap.

It can be seen that, within the error bars of the experimental data for larger shock fractions, there is very good overall agreement between the temperatures deduced from the TDS and the theoretical predictions, with the Warren model of the data implying that temperatures of order 800 K are achieved under shock compression to a value of $1 - V/V_0$ of 0.2, and rising to over 3000 K when $1 - V/V_0$ V/V_0 reaches 0.3. It should be noted that both the SESAME 3336 and LEOS 290 models make predictions for the Debye temperature itself, and for Cu at its ambient density and temperature: for both equations of state, this value is 331 K. However, the experimental value for Θ_D at STP is 311 K,⁵⁷ and as the temperature we deduce from the DW factor will scale as Θ_D^2 , using the experimental value would imply lower temperatures. Thus, we also plot in Figs. 9(c) and 9(d) the temperatures we would calculate from these two EOSs if we replaced the initial value of Θ_D by the experimental one, but then used the implied Grüneisen parameter as a function of \underline{S} volume to subsequently model Θ_D under compression. As can be \aleph seen, this leads to slightly lower temperatures in both cases, but the variation is smaller than our experimental error.

We thus conclude that within the experimental error, the ^B single-shot measurements of the TDS allow us to determine temperatures that are consistent with these EOS models, although we are still reliant on their predictions of the Debye temperature (or the Grüneisen parameter) to make this claim, much as in the same way that the EXAFS data must rely on the accuracy of potentials within the MD simulations. Nevertheless, given the importance of being able to make such single-shot temperature measurements in FEL experiments, we believe that the results we have presented here constitute an important step forward in temperature measurements from dynamically compressed solid state matter.

IV. DISCUSSION

While the temperatures that we have deduced for shocked copper are in good agreement with EOS models, it is evident from Fig. 9 that we are not yet in a position to make meaningful statements about which EOS predicts the best value for temperature. This is both because of the size of the error bars in our experimental data, as well as a lack of independent measurements of Θ_D under compression. In this section, we discuss how improvements can be made in these areas to the initial data presented here, as well as remarking on other considerations for the applicability of the technique in dynamic-compression experiments.



FIG. 9. Temperature as a function of compression for (a) those data shots where x > 0.8 and using Θ_D predicted by the equation of state (EOS) itself. (b) As (a), but including data with lower shock fractions. (c) As (a), but assuming an initial Θ_D of the experimental value of 311 K. (d) As (c), but including data with lower shock fractions. In all cases, we also show the temperatures predicted by Al'tshuler.⁴⁵ The upper x axis shows shock pressures for given compressions predicted by the SESAME 3336 and LEOS 290 EOS.

Our main source of error in deducing the DW factor at present is in our measurement of the incident x-ray flux on the target. The x-ray flux before the x-ray focusing lenses is monitored by the XGM, which has a measurement uncertainty of approximately $\pm 10\%$. IPM diodes, which reside after the x-ray focusing lenses (and thus are not affected by the lens transmission) provide a more precise reading of the x-ray intensity, but, in this initial experiment, provided signals that were corrupted upon firing of the DiPOLE laser (an issue that did not affect the XGMs). The data we provide here are thus reliant on calibrating the incident x-ray flux on unshocked targets, with the transmission of the x-ray lenses for the two different x-ray spot sizes used being determined prior to all of the DiPOLE shots, and then using the XGM readings to determine the incident x-ray flux (as described in the supplementary material). Future improvements would include better shielding of the IPM diodes such that they provide meaningful results on DiPOLE shots themselves.

Two other factors give rise to errors in our measurements: the unshocked fraction of the target at the time of data collection and the scattering from the ablator material. As for the first of these, obtaining diffraction patterns where the vast majority of the target is uniformly shocked is clearly an advantage, but should not be an issue in future experiments. It should be noted that the results presented here were obtained as a small part of the first user experiment (the EuXFEL 2740 community proposal) to be performed using the DiPOLE laser at the EuXFEL HED instrument, during which several other types of proof-of-principle studies were undertaken. As such, a limited number of shots were available. Furthermore, on this first experiment, the vast majority of the data was collected at relatively low repetition rates. In principle, DiPOLE can operate at 10 Hz, and, for at least a short duration, it has been demonstrated that DiPOLE can be operated as diffraction data are collected at Hz rates.⁵⁹ As a result, in future work, we envisage a large increase in total data collected, and no issues in timing the shock to reach to almost exactly the rear of the target.

The scattering from the ablator layer is also a factor that needs further study. First, it would be useful to have extensive studies of the scattering from the ablator at different pressures. For the work here, where Kapton was used, we do not expect any particular structure to form in the regions where we are measuring the TDS from the Cu, and in any case, the majority of the scattering from the ablator is due to Compton scattering. The various competing effects of the elastic and incoherent scattering should be taken into account when evaluating competing ablator materials (e.g., diamond). We also note that the use of any ablator will, to a degree, limit the use of this TDS technique to targets with a high enough atomic number such that the inelastic TDS from them dominates any scattering from the ablator. Furthermore, for a fixed photon energy, for lower Z targets, Compton scattering will become more of an issue.

We note that the quantity being measured by recording the TDS (the DW factor) is almost identical to that which is deduced from the EXAFS technique. When applied to the field of dynamic-compression science, each technique will find a range of applicability depending upon the experimental facility and the target under study. In any event, we are essentially measuring T/Θ_D^2 and, thus, are reliant on a model of Θ_D under compression,

which is the same as knowing the compression-dependent Grüneisen parameter (or as in the case with the recent EXAFS data, comparison is made directly with MD, and thus reliant on the fidelity of the potential used).

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It is thus of interest to ask: could we obtain information about Θ_D itself, thus allowing us to directly infer temperature? We have discussed in Sec. I that it has been shown that spectrally resolved IXS from phonons can be obtained on these timescales,^{38–40} but owing to the high resolution required, these measurements are very photon hungry. It would be useful to analyze whether using such a technique simply to glean a value for the highest phonon energy in the system (an effective measure of Θ_D), rather than explicitly attempting to directly ascertain temperature via detailed balance, may require fewer shots.

Furthermore, at least in a restricted set of conditions, it may be possible to measure Θ_D by the TDS technique discussed here. Within the work we have presented, and in our use of the Warren model, we have assumed the high-temperature limit such that the number of phonons per mode of frequency ω is simply proportional to $k_{\rm B}T/\hbar\omega$. In this case, the TDS simply depends on $T/\Theta_{\rm D}^2$. However, if the temperature is significantly lower than the Debye temperature, then the amplitude of the higher-energy phonon modes starts to be determined by their zero-point motion, which modifies the form of the TDS such that it also becomes a function of T/Θ_D ,⁶⁰ and thus, the detailed form of the TDS allows T and Θ_D to be determined separately. Of course, in many circumstances, given that typical Debye temperatures are of order room temperature (as here), the high-temperature approximation will hold in the majority of cases. However, the above issue would be interesting to explore in materials with high Debye temperatures (e.g., diamond, $\stackrel{\text{D}}{=}$ although as noted above, Compton scattering may preclude this, at least at the photon energies used here), or if dynamically compressing materials initially at very low temperature, especially if those & materials are compressed quasi-isentropically, rather than shock B compressed, such that the temperature remains low compared with the Debye temperature along the compression path. Indeed, in so-called quasi-isentropic compression, the dominant form of heating of the material to temperatures above the Debye temperature will be due to the plastic work performed, which in turn is determined by material strength, itself a material property of great interest at ultrahigh strain-rates.

The above considerations lead us then to address further improvements to the modeling. In the work presented here, we have used the classic model of Warren to calculate the TDS, and it is evident that in the regions studied, good agreement is found between it and the data. We choose this model for its simplicity of implementation, which has allowed us to readily adapt it for arbitrary ODFs, showing how the azimuthally integrated TDS is quite insensitive to texture. Several improvements to the Warren model can easily be incorporated in the future. For example, and related to the low T situation referred to above, it has been shown that it is straightforward to take into account situations where T is no longer of order or higher than Θ_D .⁶⁰ Also, Warren uses the Debye approximation of a linear dispersion relation for the phonons, but modification of the model to include non-linear dispersion as well as anisotropic materials has been developed,⁶¹ and could readily be implemented. Furthermore, much more sophisticated calculations

of the TDS, and predictions of Θ_D under compression, can be made from Density Functional Theory (DFT), with open-source software, such as the package AB2TDS,⁶² which is based on the formalism of Xu and Chiang,⁶³ available for such a purpose. Indeed, if we wish to apply this TDS method to more complicated systems, such as compounds, then the simple model of Warren will not suffice. In addition, with more accurate measurements of the TDS, it is likely that anharmonic effects will need to be taken into account, which are not incorporated into the relatively simple analysis presented here.⁶⁴

Notwithstanding all of the improvements that could evidently be made to these initial measurements, we conclude in noting that we have used the output from an x-ray FEL to measure intensity of the spectrally integrated but angularly resolved inelastic x-ray TDS from laser-shocked copper foils. Simulations using an adapted version of the classic model of Warren show that the azimuthally averaged TDS signal is insensitive to texture, but strongly dependent upon the DW factor, effectively giving a measure of T/Θ_D^2 . Using compression-dependent Debye temperatures from the SESAME 3336 and LEOS 290 EOS, we find temperatures along the Hugoniot that agree well with predicted values. We believe that in the future, the experimental errors in these single-shot measurements could be significantly reduced by more accurate measurements of the incident x-ray flux, and larger data sets with shock fractions, x, very close to unity. We posit that this technique affords a relatively straightforward method to obtain single-shot information on the temperature of a range of dynamically compressed materials on femtosecond timescales.

SUPPLEMENTARY MATERIAL

See the supplementary material for details of the algorithm used to isolate the x-ray scattering signal from the shock-compressed copper alone (including the requisite calculation of the shock fraction x) and the overall structure of the model we used to predict both the elastic and inelastic components of the x-ray scattering using the classic theory of Warren.

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AUTHOR DECLARATIONS

Conflict of Interest

The authors have no conflicts to disclose.

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DATA AVAILABILITY

The x-ray diffraction data obtained from the experiment at EuXFEL described in this article are available at https://doi.org/10. 22003/XFEL.EU-DATA-002740-00.

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